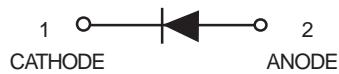
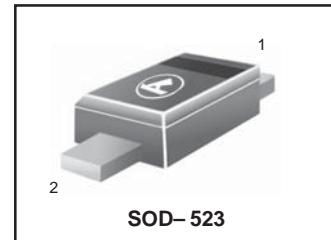


# Variable Capacitance Diode for VCXO

**HVC359**

**DEVICE MARKING**

HVC359 = S

**ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ )**

Item	Symbol	Value	Unit
Reverse voltage	$V_R$	15	V
Junction temperature	$T_j$	125	$^\circ\text{C}$
Storage temperature	$T_{stg}$	- 55 to +125	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ )**

Item	Symbol	Min	Typ	Max	Unit	Test Condition
Reverse current	$I_{R1}$	—	—	10	nA	$V_R = 10\text{V}$
	$I_{R2}$	—	—	100		$V_R = 10\text{V}, T_A = 60^\circ\text{C}$
Capacitance	$C_1$	24.8	—	29.8	pF	$V_R = 1\text{V}, f = 1 \text{MHz}$
	$C_4$	6.0	—	8.3		$V_R = 4\text{V}, f = 1 \text{MHz}$
Capacitance ratio	$n$	3.0	—	—	—	$C_1 / C_4$
Series resistance	$r_s$	—	—	1.5	$\Omega$	$V_R = 4\text{V}, f = 100 \text{MHz}$
ESD-Capability <sup>1</sup>	—	80	—	—	V	C = 200pF, Both forward and reverse direction 1 pulse.

 Notes 1. Failure criterion ;  $I_R \geq 20\text{nA}$  at  $V_R = 10\text{V}$

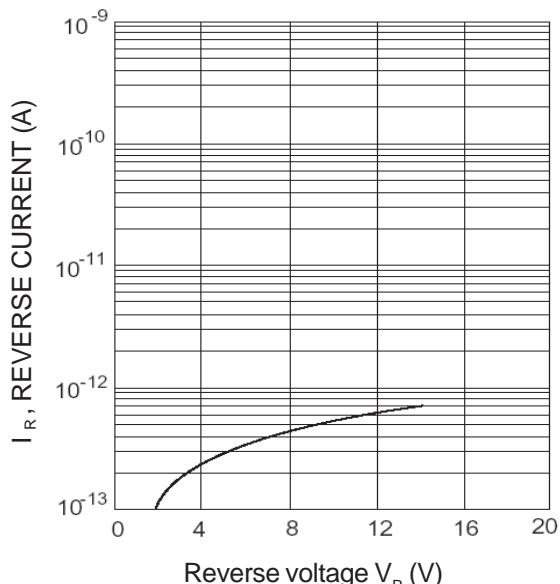
**HVC359**

Fig.1 Reverse current Vs. Reverse voltage

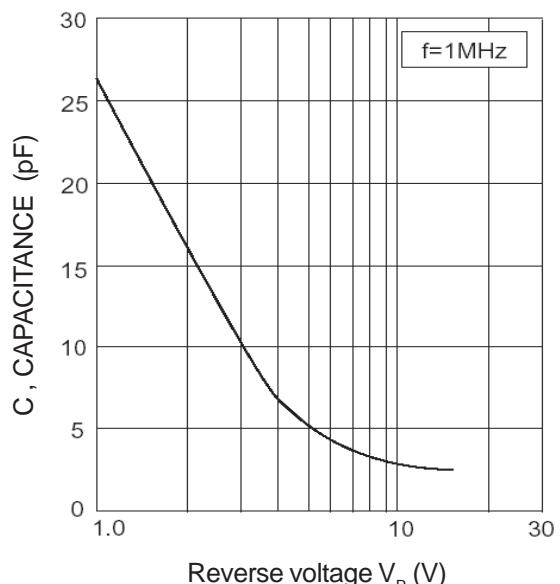


Fig.2 Capacitance Vs. Reverse voltage